

Notice of References Cited	Application/Control No. 10/065,482		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Satish S. Rampuria		Art Unit 2191	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-2003/0088868 A1	05-2003	Chang et al.	717/173
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NON-PATENT DOCUMENTS

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